Index of Claims

Appl	lica	tion/	Con	trol	No.	

10815708 Examiner

Choi, Michael P

Applicant(s)/Patent Under Reexamination YOO ET AL.

5/08

Art Unit

2621

RejectedAllowed

-	Cancelled
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N	Non-Elected
1	Interference

Α	Appeal
0	Objected

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Examiner Art Unit

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=	Allowed	÷	Restricted		1	Interference	0	Objected

Choi, Michael P

Non-Elected	Α	Appeal	
Interference	0	Objected	

☐ Claims	renumbered	in the same	order as pr	esented by	applicant		☐ CPA	□ т.с). 🗆	R.1.47
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